

Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 128096		APPLICATION NO. 10/580,436	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANT(S) Shinsuke OKADA et al.			
				FILING DATE May 24, 2006		GROUP	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
/A.O.A./	1	2002/0172639 A1	11/21/2002	Horiuchi et al.			
/A.O.A./	2	6,340,822 B1	01/22/2002	Broen et, al.			
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/A.O.A./	3	JP A 2002-346996	12/4/2002	Japan	X	X	
	4	JP A 58-98333	06/11/1983	Japan	X		
	5	JP A 59-32166	02/21/1984	Japan	X		
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/A.O.A./	13	YAMADA, T.; (2002); "Modeling of kink-shaped carbon-nanotube Schottky diode with gate bias modulation"; APPLIED PHYSICS LETTERS, 80(21); pp. 4027-4029					
/A.O.A./	14	FREITAGE, M., et al.; (2001); "Controlled creation of a carbon nanotube diode by a scanned gate"; APPLIED PHYSICS LETTERS, 79(20); pp. 3326-3328					
EXAMINER /Andrew O. Arena/							
				DATE CONSIDERED 07/01/2010			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: September 5, 2006